

TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

2SC4320

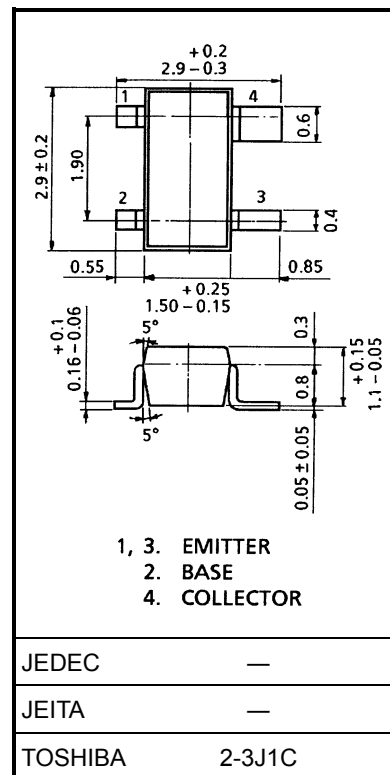
VHF~UHF Band Low Noise Amplifier Applications

Unit: mm

- Low noise figure, high gain.
- $NF = 1.1\text{dB}$, $|S_{21e}|^2 = 15\text{dB}$ ($f = 1\text{GHz}$)

Maximum Ratings ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	20	V
Collector-emitter voltage	V_{CEO}	10	V
Emitter-base voltage	V_{EBO}	1.5	V
Base current	I_B	20	mA
Collector current	I_C	40	mA
Collector power dissipation	P_C	150	mW
Junction temperature	T_j	125	$^\circ\text{C}$
Storage temperature range	T_{stg}	$-55\sim 125$	$^\circ\text{C}$

Microwave Characteristics ($T_a = 25^\circ\text{C}$)

Weight: 0.012 g (typ.)

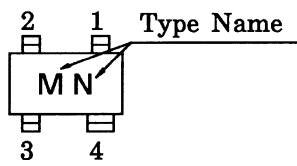
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Transition frequency	f_T	$V_{CE} = 8\text{ V}$, $I_C = 20\text{ mA}$	7	10	—	GHz
Insertion gain	$ S_{21e} ^2 (1)$	$V_{CE} = 8\text{ V}$, $I_C = 20\text{ mA}$, $f = 1\text{ GHz}$	12	15	—	dB
	$ S_{21e} ^2 (2)$	$V_{CE} = 8\text{ V}$, $I_C = 20\text{ mA}$, $f = 2\text{ GHz}$	—	9	—	
Noise figure	NF (1)	$V_{CE} = 8\text{ V}$, $I_C = 5\text{ mA}$, $f = 1\text{ GHz}$	—	1.1	2.5	dB
	NF (2)	$V_{CE} = 8\text{ V}$, $I_C = 5\text{ mA}$, $f = 2\text{ GHz}$	—	1.7	—	

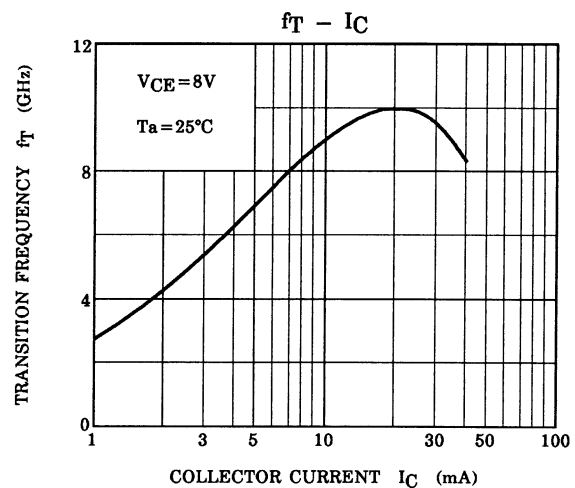
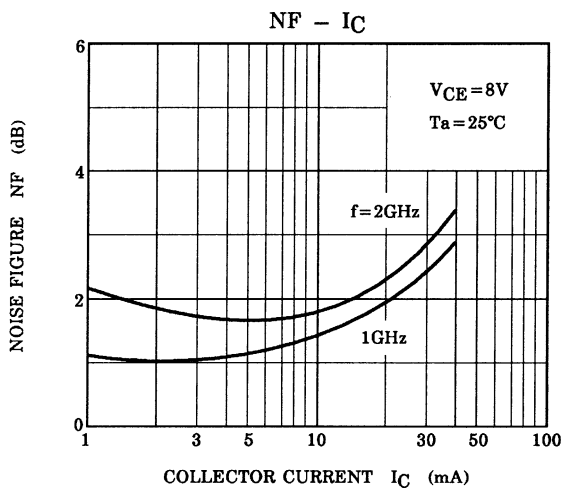
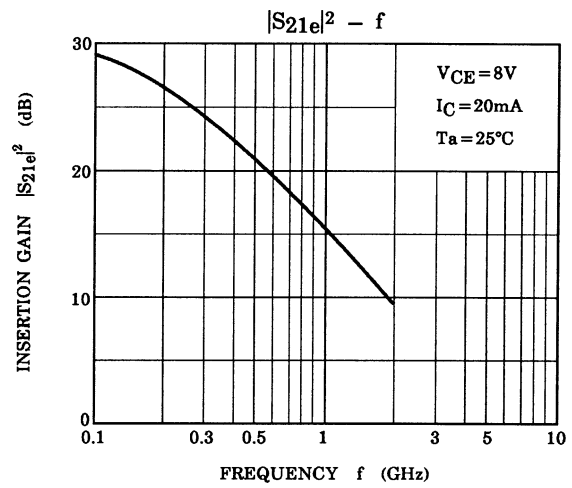
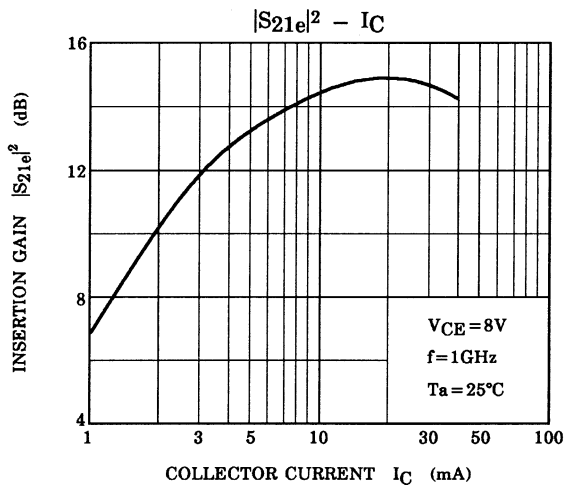
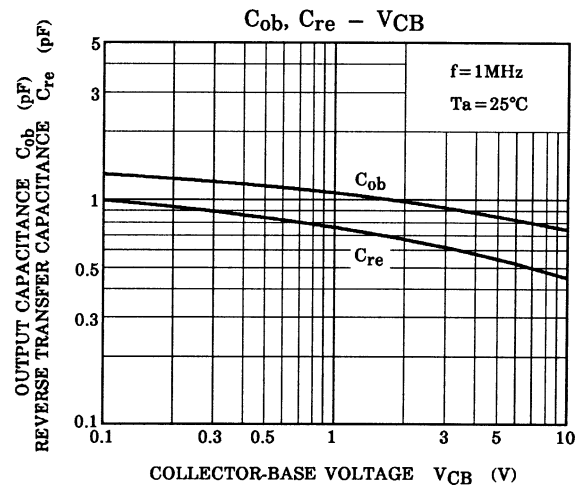
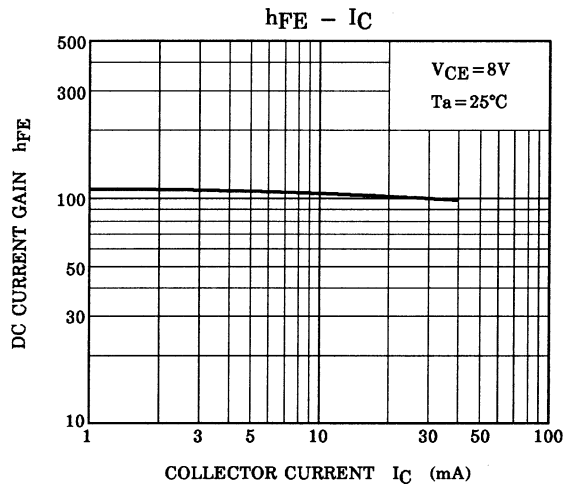
Electrical Characteristics ($T_a = 25^\circ\text{C}$)

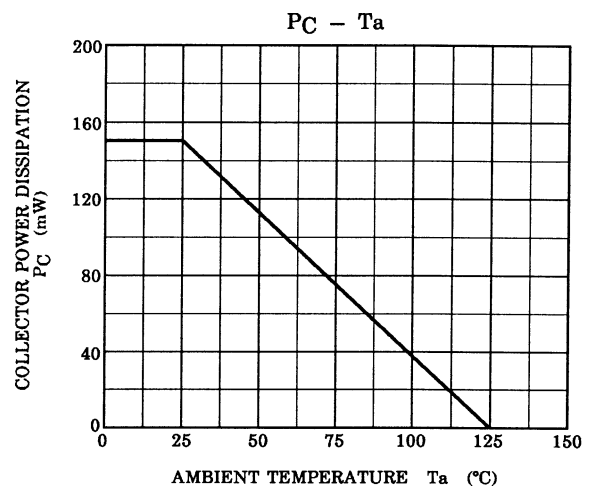
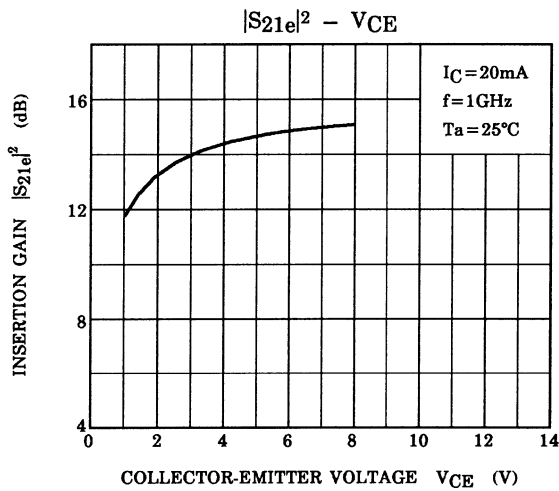
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	I_{CBO}	$V_{CB} = 10\text{ V}$, $I_E = 0$	—	—	1	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = 1\text{ V}$, $I_C = 0$	—	—	1	μA
DC current gain	h_{FE}	$V_{CE} = 8\text{ V}$, $I_C = 20\text{ mA}$	50	—	250	
Output capacitance	C_{ob}	$V_{CB} = 10\text{ V}$, $I_E = 0$, $f = 1\text{ MHz}$ (Note)	—	0.75	—	pF
Reverse transfer capacitance	C_{re}		—	0.45	0.9	pF

Note: C_{re} is measured by 3 terminal method with capacitance bridge.

Marking







S-Parameter $Z_0 = 50 \Omega$, $T_a = 25^\circ\text{C}$

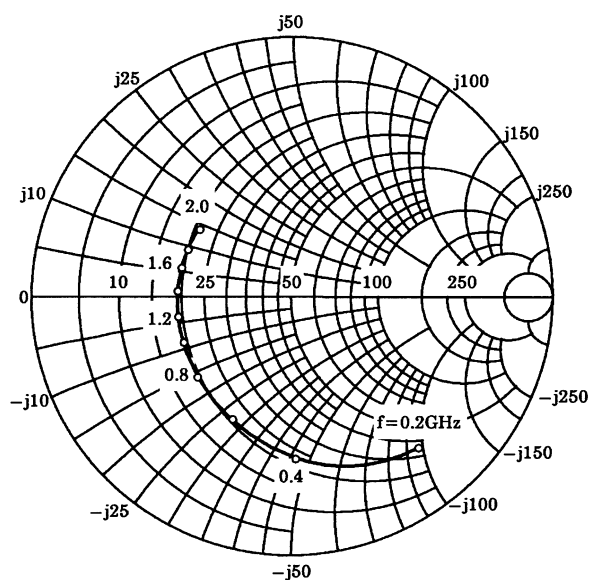
$V_{CE} = 8 \text{ V}$, $I_C = 5 \text{ mA}$

Frequency MHz	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
200	0.764	-49.6	11.754	147.1	0.047	64.2	0.869	-29.4
400	0.624	-87.9	8.966	124.6	0.072	48.9	0.669	-48.3
600	0.532	-115.7	6.947	110.5	0.084	42.1	0.526	-59.5
800	0.485	-137.5	5.581	100.4	0.091	39.3	0.429	-66.6
1000	0.446	-155.0	4.636	92.9	0.097	38.6	0.370	-71.3
1200	0.441	-169.2	4.003	86.3	0.102	38.8	0.330	-75.3
1400	0.432	177.1	3.487	80.1	0.107	39.6	0.305	-77.6
1600	0.426	166.1	3.144	75.1	0.114	40.1	0.288	-80.7
1800	0.431	154.4	2.900	70.0	0.119	41.9	0.276	-83.9
2000	0.425	145.2	2.652	65.5	0.127	43.1	0.272	-87.3

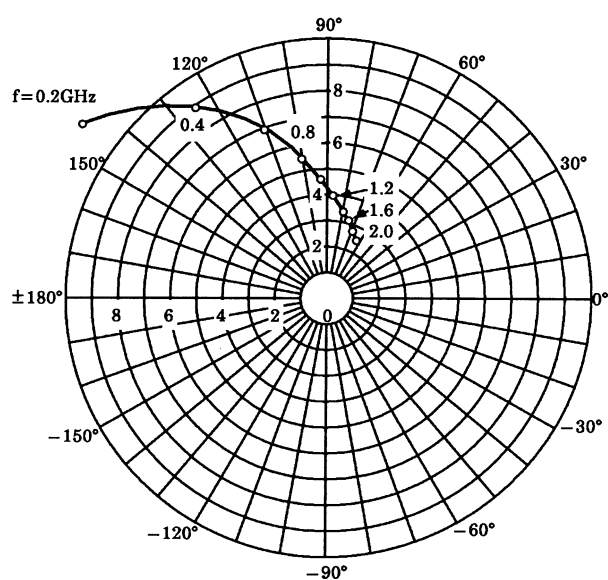
$V_{CE} = 8 \text{ V}$, $I_C = 20 \text{ mA}$

Frequency MHz	S11		S21		S12		S22	
	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
200	0.540	-90.3	21.037	129.7	0.033	55.7	0.670	-46.8
400	0.479	-134.8	13.017	108.7	0.046	50.0	0.417	-64.5
600	0.461	-159.4	9.230	98.1	0.054	51.2	0.297	-71.9
800	0.454	-176.0	7.117	90.5	0.063	54.1	0.230	-75.4
1000	0.454	170.7	5.816	85.1	0.073	56.1	0.191	-76.7
1200	0.452	160.0	4.944	79.8	0.084	57.9	0.168	-77.0
1400	0.461	149.1	4.299	74.7	0.094	58.7	0.156	-75.7
1600	0.459	140.7	3.838	70.6	0.105	59.0	0.151	-75.8
1800	0.461	131.9	3.483	66.0	0.117	59.4	0.154	-76.6
2000	0.450	124.2	3.171	61.8	0.130	59.0	0.161	-79.3

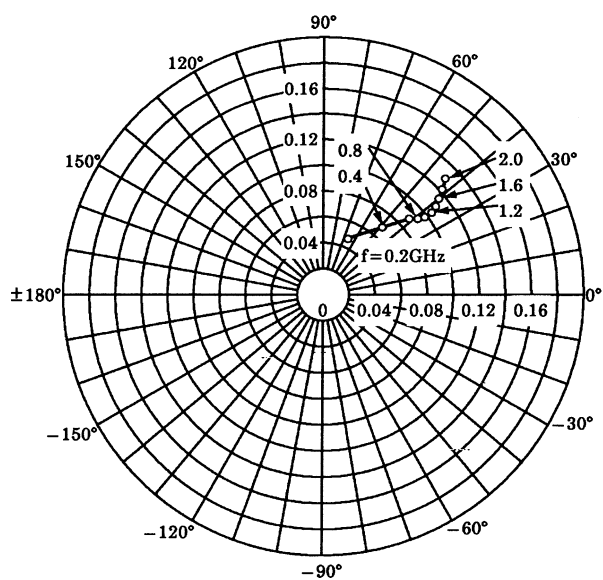
S_{11e}
 $V_{CE}=8V$
 $I_C=5mA$
 $T_a=25^{\circ}C$
 (UNIT : Ω)



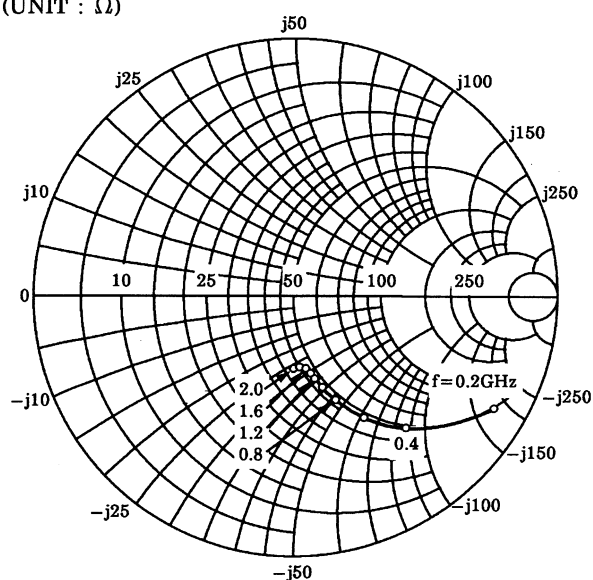
S_{21e}
 $V_{CE}=8V$
 $I_C=5mA$
 $T_a=25^{\circ}C$



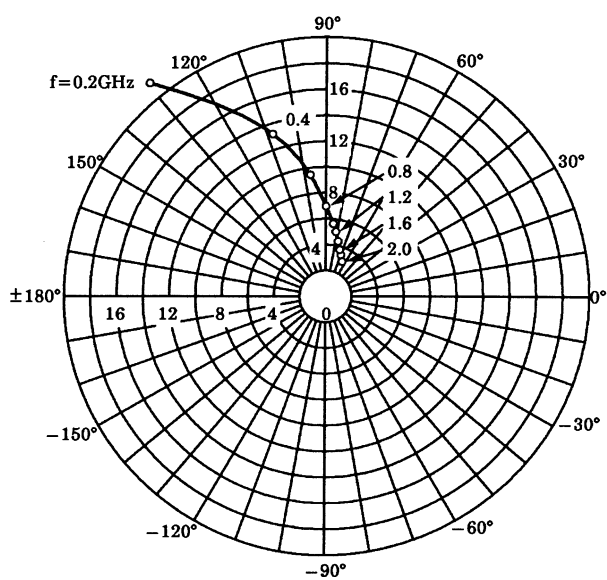
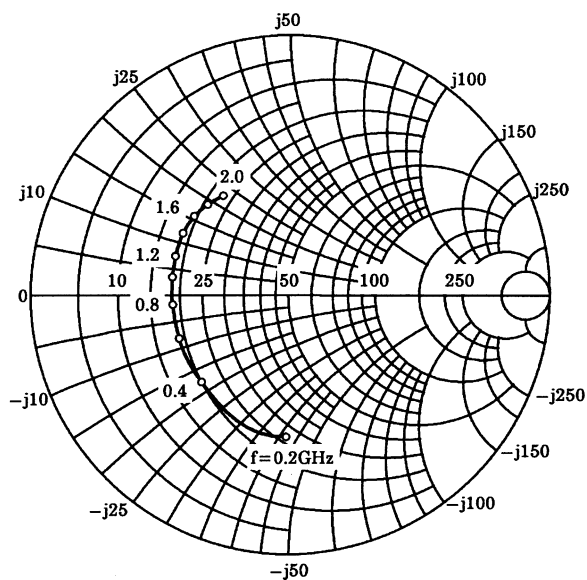
S_{12e}
 $V_{CE}=8V$
 $I_C=5mA$
 $T_a=25^{\circ}C$



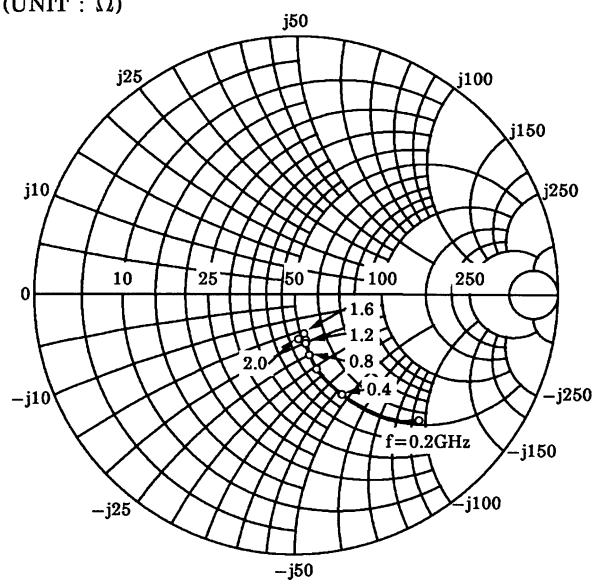
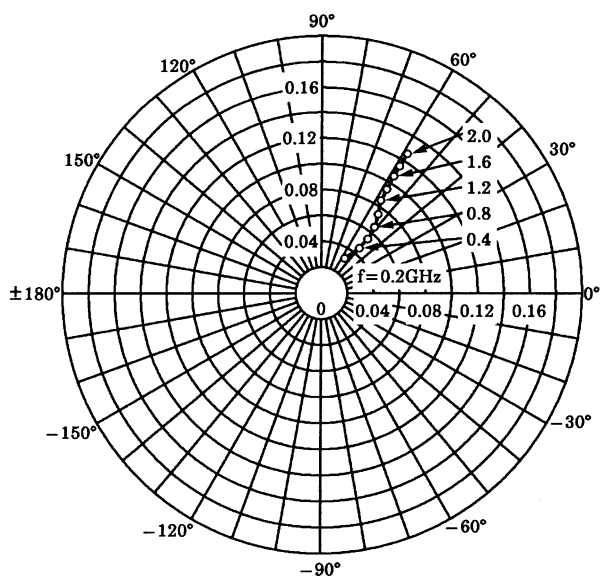
S_{22e}
 $V_{CE}=8V$
 $I_C=5mA$
 $T_a=25^{\circ}C$
 (UNIT : Ω)



S21e
VCE=8V
IC=20mA
Ta=25°C



S22e
V_{CE} = 8V
I_C = 20mA
T_a = 25°C
(UNIT : Ω)



RESTRICTIONS ON PRODUCT USE

000707EAA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.